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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/729,193	12/05/2000	Katsuhisa Yuda	11P348157	6697
466	7590	08/22/2003	12	
YOUNG & THOMPSON 745 SOUTH 23RD STREET 2ND FLOOR ARLINGTON, VA 22202			EXAMINER	
		ALEJANDRO MULERO, LUZ L		
		ART UNIT	PAPER NUMBER	
		1763		

DATE MAILED: 08/22/2003

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary	Application No.	Applicant(s)	
	09/729,193	YUDA, KATSUHISA	
	Examiner Luz L. Alejandro	Art Unit 1763	

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --
Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) Responsive to communication(s) filed on 17 June 2003.
- 2a) This action is FINAL. 2b) This action is non-final.
- 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) Claim(s) 1,2,4 and 5 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) Claim(s) _____ is/are allowed.
- 6) Claim(s) 1,2,4 and 5 is/are rejected.
- 7) Claim(s) _____ is/are objected to.
- 8) Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) The specification is objected to by the Examiner.
- 10) The drawing(s) filed on _____ is/are: a) accepted or b) objected to by the Examiner.
 Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- 11) The proposed drawing correction filed on _____ is: a) approved b) disapproved by the Examiner.
 If approved, corrected drawings are required in reply to this Office action.
- 12) The oath or declaration is objected to by the Examiner.

Priority under 35 U.S.C. §§ 119 and 120

- 13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) All b) Some * c) None of:
 1. Certified copies of the priority documents have been received.
 2. Certified copies of the priority documents have been received in Application No. _____.
 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- * See the attached detailed Office action for a list of the certified copies not received.
- 14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).
 a) The translation of the foreign language provisional application has been received.
- 15) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.

Attachment(s)

- 1) Notice of References Cited (PTO-892)
 2) Notice of Draftsperson's Patent Drawing Review (PTO-948)
 3) Information Disclosure Statement(s) (PTO-1449) Paper No(s) 7, 10.
- 4) Interview Summary (PTO-413) Paper No(s). _____.
 5) Notice of Informal Patent Application (PTO-152)
 6) Other: _____

DETAILED ACTION

Continued Examination Under 37 CFR 1.114

A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 6/17/03 has been entered.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

Claims 1-2 and 4-5 are rejected under 35 U.S.C. 103(a) as being unpatentable over NEC Corp., JP 11-168094 in view of Kuthi et al., U.S. Patent 6,106,663 or Tatsuo et al., JP 03-197684.

With respect to claim 1, NEC Corp., shows in fig. 5, the invention substantially as claimed including a plasma CVD apparatus comprising a substrate processing zone 10 with a deposition substrate 4 disposed therein, a plasma generating zone 6 for generating plasma of first gas; and a plasma confining electrode 29, having a hollow structure, for separating the substrate processing zone and the plasma generating

zone, and confining the first gas passed through the inlet 5, and having holes for passing first gas containing neutral radicals from the first gas plasma such that the first gas is uniformly supplied to the substrate processing zone, wherein: the plasma confining electrode has holes for introducing a second gas into the substrate processing zone to form a desired film on the deposition substrate by gas phase chemical reaction between the first gas containing neutral radicals and the second gas. With respect to the plasma confining electrode with the holes for introducing the second gas into the substrate processing zone being vertically spaced apart from the deposition substrate by a distance not greater than 1500 times the mean free path of the blend gas of neutral radicals and the second gas, note that in figure 27 the reference discloses that the spacing between the deposition substrate and the plasma confining electrode is less than 120 millimeters. Furthermore, the reference discloses that the distance can be just 0-60 mm (see paragraphs 0094-0098 of the English translation).

With respect to claim 4 NEC Corp. shows, in figs. 1-4, the invention substantially as claimed including a plasma CVD apparatus comprising a substrate processing zone 10 with a deposition substrate 4 disposed therein, a plasma generating zone 6 for generating plasma of first gas, and a plasma confining electrode 11 for separating the substrate processing zone and the plasma generating zone and confining the first gas passed through the inlet 5 and having holes for passing first gas containing neutral radicals from the first gas plasma such that the first gas is uniformly supplied to the substrate processing zone, wherein: the plasma CVD apparatus further comprises a gas introducing member 24 (see Figure 4) disposed between the plasma confining

electrode member 11 and the deposition substrate 4, having a hollow structure, and having a plurality of holes through which second gas is introduced into the substrate processing zone to form a desired film on the deposition substrate by gas phase chemical reaction between the first gas containing neutral radicals and the second gas; the gas introducing member is vertically spaced apart from the substrate processing zone (see abstract and the figures). With respect to the gas introducing member with the holes for introducing the second gas into the substrate processing zone being vertically spaced apart from the deposition substrate by a distance not greater than 1500 times the mean free path of the blend gas of neutral radicals and the second gas, note that in figure 27 the reference discloses that the spacing between the deposition substrate and the gas introducing member is less than 120 millimeters. Furthermore, the reference discloses that the distance can be just 0-60 mm (see paragraphs 0094-0098 of the English translation).

NEC Corp. does not expressly disclose either that the plasma confining electrode accommodates horizontal gas dispersion plates within the hollow structure (claim 1) or that the gas introducing member accommodates horizontal gas dispersion plates within the hollow structure (claim 4). Kuthi et al., U.S. Patent 6,106,663 discloses horizontal gas dispersion plates 122 within a hollow gas introducing member electrode 114 (see Fig. 1B and col. 1-lines 53-67). Alternatively, Tatsuo et al. discloses horizontal gas dispersion plates 21 within a hollow gas introducing member where both first and second gases interact (see abstract and fig. 2). In view of this disclosure, it would have been obvious to one of ordinary skill in the art at the time the invention was made to

modify the apparatus of NEC Corp. so as to include the horizontal gas dispersion plates within the hollow structure so as to, for example, introduce the second gas into the substrate processing zone as taught by Kuthi et al. and Tatsuo et al. because this will allow for more uniform flow of gas to the processing region.

Response to Arguments

Applicant's arguments filed 6/17/03 have been fully considered but they are not persuasive.

Applicant argues that the proposed modifications are not viable. However, the test for obviousness is not whether the features of a secondary reference may be bodily incorporated into the structure of the primary reference; nor is it that the claimed invention must be expressly suggested in any one or all of the references. Rather, the test is what the combined teachings of the references would have suggested to those of ordinary skill in the art. See *In re Keller*, 642 F.2d 413, 208 USPQ 871 (CCPA 1981).

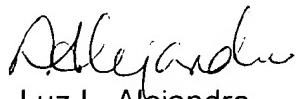
Concerning the fact that Kuthi et al. fails to show first and second gases, one cannot show nonobviousness by attacking references individually where the rejections are based on combinations of references. See *In re Keller*, 642 F.2d 413, 208 USPQ 871 (CCPA 1981); *In re Merck & Co.*, 800 F.2d 1091, 231 USPQ 375 (Fed. Cir. 1986).

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Luz L. Alejandro whose telephone number is 703-305-4545. The examiner can normally be reached on Monday to Thursday from 7:30 to 6:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Gregory L. Mills can be reached on 703-308-1633. The fax phone numbers for the organization where this application or proceeding is assigned are 703-872-9310 for regular communications and 703-872-9311 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-308-0661.


Luz L. Alejandro
Primary Examiner
Art Unit 1763

August 18, 2003